

WHAT IS CLAIMED IS:

1. A method of operating a sense amplifier to read data stored in a memory cell, the method comprising steps of:
 - 5 pre-charging a bit-line of the memory cell to a predetermined reference voltage substantially equal to a trip point of the sense amplifier using a pre-charge circuit;
 - developing a voltage signal representing data stored in the memory cell;
 - reconfiguring the pre-charge circuit as a regeneration circuit; and
 - amplifying the voltage signal using the regeneration circuit.
- 10 2. A method according to claim 1, further including the step of pre-charging a node of a cascode device coupled to the bit-line of the memory cell.
- 15 3. A sense amplifier to read a multi-state memory cell having a field effect transistor (FET) with a source, a drain and a bit-line, the sense amplifier comprising:
 - 20 a cascode device coupled to the drain of the FET of the memory cell, the cascode device adapted to increase the resolution of the sense amplifier during a read mode and to isolate the sense amplifier from a high voltage applied to the memory cell during a write mode; and
 - 25 a pre-charge circuit coupled to the cascode device, the pre-charge circuit configured to pre-charge the bit-line of the memory cell through the cascode device during a pre-charge mode to reduce time required to read the multi-state memory cell.
- 30 4. A sense amplifier according to claim 3, wherein the cascode device is an coupled in series between the pre-charge circuit and the drain of the FET in the memory cell.
5. A sense amplifier according to claim 3, wherein the pre-charge circuit comprises a unity gain buffer having an input to which a predetermined reference voltage is applied, and an output coupled to provide a bias current

(I_{BIAS}) to the cascode device to pre-charge the bit-line by charging a node of the cascode device to the predetermined reference voltage.

6. A sense amplifier according to claim 5, wherein the pre-charge circuit further comprises a transistor switch to couple the unity gain buffer to the cascode device during the pre-charge mode and to de-couple the unity gain buffer from the cascode device during a develop mode.
7. A sense amplifier according to claim 6, further comprising a reference current circuit to provide a reference current (I_{REF}), wherein in the develop mode a difference between I_{REF} and a current through the memory cell (I_{CELL}) causes a change from the predetermined reference voltage to which the node of the cascode device is charged to develop a voltage signal representing data stored in the memory cell.
- 15 8. A sense amplifier according to claim 7, wherein the pre-charge circuit is re-configurable as a regeneration circuit during a regeneration mode to amplify the voltage signal developed during the develop mode.
- 20 9. A multi-state memory comprising a sense amplifier according to claim 3, the multi-state memory further comprising:
a plurality of multi-state memory cells capable of storing data therein; and
a high-voltage supply for writing data to the multi-state memory cells.
10. In a memory having at least one multi-state memory cell capable of storing data therein and a sense amplifier capable of reading data stored in the memory cell, the sense amplifier having a cascode device coupled to the memory cell and a pre-charge circuit for pre-charging a bit-line of the memory cell through the cascode device, a method of operating the memory to read data stored in the multi-state memory cell, the method comprising the steps of:
coupling the pre-charge circuit to the cascode device;
pre-charging the bit-line of the memory cell through the cascode device

to a predetermined reference voltage;
de-coupling the pre-charge circuit from the cascode device;
developing a voltage signal representing data stored in the memory cell;
reconfiguring the pre-charge circuit as a regeneration circuit; and
amplifying the voltage signal using the regeneration circuit.

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11. A method according to claim 10, wherein the pre-charge circuit comprises a unity gain buffer having an output switchably coupled to the cascode device, and wherein the step of coupling the pre-charge circuit to the cascode device includes applying a control signal to couple the output to the cascode device.

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12. A method according to claim 11, wherein the step of pre-charging the cascode device to a predetermined reference voltage includes:

applying the predetermined reference voltage to an input of the unity gain buffer; and

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applying a bias current (I_{BIAS}) from the unity gain buffer to the cascode device to pre-charge the bit-line of the memory cell by charging the node of the cascode device to the predetermined reference voltage.

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13. A method according to claim 12, wherein the sense amplifier further comprises a reference current circuit to provide a reference current (I_{REF}) to the cascode device, and wherein the step of pre-charging the cascode device to a predetermined reference voltage includes applying I_{REF} and I_{BIAS} simultaneously to the cascode device to pre-charge the bit-line through the cascode device to the predetermined reference voltage.

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14. A method according to claim 13, wherein the step of developing a voltage signal includes enabling a difference between I_{REF} and a current through the memory cell (I_{CELL}) to cause a change from the predetermined reference voltage to which the cascode device is charged.

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15. A method according to claim 10, wherein the step of reconfiguring the

pre-charge circuit as a regeneration circuit includes forming an amplifier having a positive feedback loop.

16. A method according to claim 15, wherein the pre-charge circuit comprises a unity gain buffer, and wherein forming an amplifier includes forming the
5 amplifier using components comprising the unity gain amplifier.

17. A method according to claim 15, wherein the step of amplifying the voltage signal includes amplifying the voltage signal using the amplifier.

10 18. A multi-state memory comprising:
at least one multi-state memory cell capable of storing data therein;
a sense amplifier capable of reading data stored in the memory cell, the sense amplifier including:
a cascode device coupled to the memory cell;
15 means for pre-charging a bit-line of the at least one multi-state memory cell through the cascode device;
means for developing a voltage signal representing data stored in the memory cell; and
means for amplifying the voltage signal.
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19. A multi-state memory according to claim 18, wherein the means for pre-charging includes a pre-charging circuit comprising a unity gain buffer having an input to which a predetermined reference voltage is applied, and an output coupled to provide a bias current (I_{BIAS}) to the cascode device to pre-charge the
25 bit-line by charging the node of the cascode device to the predetermined reference voltage.

20. A multi-state memory according to claim 19, wherein the means for developing a voltage signal comprises:

30 means for decoupling the output of the pre-charge circuit from the cascode device; and

a reference current circuit to provide a reference current (I_{REF}) to the cascode device;

wherein a difference between I_{REF} and a current through the memory cell (I_{CELL}) causes a change from the predetermined reference voltage to which the node of the cascode device is charged.

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21. A multi-state memory according to claim 19, wherein the means for amplifying the voltage signal comprises a regeneration circuit having an amplifier with a positive feedback loop.

10 22. A multi-state memory according to claim 21, wherein the pre-charging circuit comprises components of the unity gain amplifier coupled together in a first configuration, and wherein the regeneration circuit comprises components of the unity gain amplifier coupled together in a second configuration.